# **Development of ATLAS Radiation Monitor**

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# **ATLAS radiation monitors**

- Instantaneous:
  - Beam Condition Monitor BCM

EDMS document: ATL-IC-ES-0013

- Integrating on-line
  - Total Ionization Dose TID
  - Non-Ionizing Energy Loss NIEL
  - Thermal Neutrons

EDMS document: *ATL-IC-ES-0017* 

- Integrating off-line
  - TLD, counting on common LHC effort



# **On-line monitoring**

Constraints for on-line monitors:

- Use of standard ATLAS DCS components
   already qualified for use in ATLAS
- Size of the sensor boards
  - dimensions in ATLAS: 8 mm x 4 cm x 4 cm
- Cables from user-accessible area *PP2 inside muon system* to *PP1* (allocated few years ago):
  - Type II cable: 12 thin wires 0.22  $\Omega/m$ , 4 thick wires 0.033  $\Omega/m$ → limits the number of sensors per monitoring board
- Choice of locations limited



## Schematic view of the on-line monitor



#### **Position of Radiation Monitoring Sensor Boards (RMSB)**



Sensors planned to be used on RMSB

Monitor Total Ionizing Dose (TID):

- RADFET's (threshold voltage increase)
  - High-sensitivity (thick oxide) for LHC startup
  - Low-sensitivity (thin oxide) to cover standard 3+7 scenario

Monitor NIEL:

- EPI PIN-diodes (leakage current increase with NIEL)
  - Rely on  $\Delta I/V = \alpha \times \Phi$
  - EPI thin (25  $\mu m)$  substrate depleted at < 30 V
- PIN diodes under forward bias (resistivity increase with NIEL)
  - OSRAM BPW 34F high fluence (sensitivity around 10<sup>13</sup> n/cm<sup>2</sup>)
  - High sensitivity diodes low fluence (sensitivity around 10<sup>10</sup> n/cm<sup>2</sup>)



#### Monitor thermal neutrons:

• DMILL bipolar transistor from ATMEL (test structures from ABCD3T production wafers)

- Common emitter current gain degrades with fluence
- Sensitivity to thermal neutrons  $\sim$  3 x NIEL
- Provides direct monitoring of damage on ABCD3T input transistor

#### **Temperature control**

- all types of sensors are sensitive to temperature
- temperature should be stable to simplify analysis (annealing...)

Stabilization achieved by heating sensor boards to few degrees above environment temperature of ~20°C.



#### NIEL monitoring – epi-Si diodes

# Measurement principle: reverse bias leakage current increase in diode after irradiation $\Delta I/V = \alpha \times \Phi_{eq}$ .

Samples (ITME grown epi-Si, CiS process) •25 µm epi-Si ,  $\rho_{initial}$ =50 Ωcm,  $V_{fd}$ =25 V, 5x5 mm<sup>2</sup> •  $V_{fd}$  always less that 28 V (limited by DAC)



25  $\mu$ m n-type epitaxial layer

**Cz substrate (300** μ**m)** [O] > 10<sup>18</sup> cm<sup>-3</sup>

irradiated with neutrons at JSI reactor in Ljubljana
Irradiated with 23 GeV protons at CERN PS

# Measured leakage currents are in accordance with expectations

Operational ( $V_{fd} < 28$  V) even at  $10^{15}$  cm<sup>-2</sup> !

#### Annealing studies performed at 20°C



epi-Si can be sensitive also during low luminosity running!



#### NIEL monitoring – OSRAM PIN (BPW 34F)

#### Measurement of forward bias resistance of irradiated PIN diodes



Several samples irradiated with neutrons at JSI reactor in Ljubljana:

- •Better linearity with fluence at higher current
- •Annealing does play a significant role



#### NIEL monitoring – high-sensitive PIN



#### Irradiation of single diode in steps

- •One minute between two fluence points
- •Excellent sensitivity for low fluences
- •Annealing could be important studies in progress



#### **DMILL structures**



Same transistor as input transistor of ABCD3T readout chip







# **Read-out**

#### **ELMB + DAC boards**:

ELMB available, 64 ADC channels
DAC boards will be produced next year (prototypes were tested), 4 boards (16 channels each) per ELMB Fully compatible with ATLAS DCS (CAN bus communication)

Compliant with radiation tolerance requirements

#### 3-4 "RM sensor boards" per ELMB:





 DACs: with external power supply of 30 V
 •current output: 0-1 mA maximum voltage drop 28 V (sensors) 0-10 mA maximum voltage drop 10 V (heaters)
 •voltage output: current drop over the resistor

#### **ADCs:** 64 (12 bit)

•conversion rate from 2-100 Hz

•different dynamic ranges can be selected

•use of attenuators, Pt1000 readouts etc. with resistor/capacitor network plugs

# <u>Readout principles</u> **RADFET,PIN:** current enforced (DAC)-voltage measured (ADC) **EPI:** current (DAC) converted to voltage (resistor) – voltage drop on resistor due to leakage current measured (ADC) **DMILL:** collector current enforced (DAC) – voltage drop on resistor due to base current measured (ADC)

#### HEATER: 3-5 DAC channels (200 mW/ch.) connected together





#### **Sensor board**

Sensor boards will be made on square inch AIN ceramics:

- •600  $\mu m$  thick
- •bondable (Au) and solderable contacts (Pd-Ag)
- •good heat conductance (140-177 W/m K)
- •high resistivity  $(10^{10} \,\Omega cm)$

Board will be connected through PCB frame (mechanical support and thermal isolation)

### Prototype





#### First test - readout

#### **ELMB readout:**

- 12 m Type II cables
- No DAC's available yet use Keithley current source
- Read-out over CAN-bus
- $\rightarrow$  successful readout of all types of sensors demonstrated



#### **Heater test**

#### First tests:

•At least 3 DAC channels 200 mW each planned for heater

→enough power for stabilization of temperature of RMSB



#### **Future plans**

#### **SENSOR studies:**

•PIN BPW 34F – continue annealing at 20°C and start it also at 30°C to get data for Arrhenius relation interpolation

DMILL – already irradiated with n and p (CERN PS), annealing studies will follow
EPI – annealing studies (n,p irradiated samples) to verify the predicted behavior (M. Molls thesis)

#### **RM board development:**

population of the prototype boards with sensors
development of housing (PEEK plastics – radiation hard up to 1 GRad)
studies of realistic thermal properties of the sensor

#### DAC:

•first series will be commissioned soon

#### **READ-OUT:**

•PVSSII software development (has already started)

